

Sheet 1 of 1

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)	ATTORNEY DOCKET NO. 1344.1137	APPLICATION NO. 10/798,267
	FIRST NAMED INVENTOR Yasushi SUGAYA, et al.	
	FILING DATE March 12, 2004	GROUP ART UNIT 3663

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
EP	AA	2001/019448	09/06/01	Ryu			
EP	AB	2001/046083	11/29/01	Youichi et al.			
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	TRANSLATION YES NO		ABSTRACT
EP	AG	1 385 280 A2	01/28/04	EP	xx		
EP	AH	1 376 905 A2	01/02/04	EP	xx		
	AI						
	AJ						
	AK						
	AL						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

TRANSLATION
YES NO

	AM	EP Search Report for corresponding EP application 04005961.0-2222-		
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EXAMINER Eric Bolda	DATE CONSIDERED 1/18/06
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	



Sheet 1 of 2

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTORNEY DOCKET NO. 1344.1137	APPLICATION NO. 10/798,267
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)		FIRST NAMED INVENTOR Yasushi SUGAYA, et al.	
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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
EB	AA	6,636,344	10/21/03	Akasaka et al.			
EB	AB	6,510,000	01/21/03	Onaka et al.			
EB	AC	2002-12161A	01/31/02	Tsuzaki et al.			
EB	AD	2002-0044336 A	04/18/02	Tanaka et al.			
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO	
EB	AG	09-064446	03/07/97	Japan			xx	
	AH	2002-40496	02/06/02	Japan (corresponds to US 2002-12161A)				xx
	AI	2002-072262	03/12/02	Japan			abs	
	AJ	2000-98433	04/07/00	Japan (corresponds to USP 6,636,334)				xx
	AK	2002-76482	03/15/02	Japan (corresponds to USP 6,510,000)				xx
EB	AL	WO 02/21204	03/14/02	PCT (corresponds to 2002-044336 A)				xx

EXAMINER Eric Boldt	DATE CONSIDERED 1/31/06
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	BA						
	BB						
	BC						
	BD						
	BE						
	BF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO
	BG						
	BH						
	BI						
	BJ						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

EB	BK	"Observation of Catastrophic Self-Propelled Self-Focusing In Optical Fibres", Electronic Letters, Vol. 24, No. 1, pgs. 48-49, Jan. 1988
EB	BL	D.P. Hand, et al., "Solitary Thermal Shock Waves And Optical Damage In Optical Fibers: The Fiber Fuse," Optics Letters, Vol., 13, No. 9, pgs. 767-769, Sept. 1988
EB	BM	M. Wegmuller, et al., "Distributed Gain Measurements In Er-Doped Fibers With High Resolution and Accuracy Using An Optical Frequency Domain Reflectometer," Journal of Lightwave Technology, Vol. 18, No. 12, pgs. 2127-2132, Dec. 02
EB	BN	J.P. von der Weid, et al., "On the Characterization of Optical Fiber Network Components with Optical Frequency Domain Reflectometry," Journal of Lightwave Technology, Vol. 15, No. 7, pgs. 1131-1141, July 97

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